



International
Standard

ISO 25498

**Microbeam analysis — Analytical
electron microscopy — Selected
area electron diffraction analysis
using a transmission electron
microscope**

*Analyse par microfaisceaux — Microscopie électronique
analytique — Analyse par diffraction par sélection d'aire au
moyen d'un microscope électronique en transmission*

**Third edition
2025-05**



COPYRIGHT PROTECTED DOCUMENT

© ISO 2025

All rights reserved. Unless otherwise specified, or required in the context of its implementation, no part of this publication may be reproduced or utilized otherwise in any form or by any means, electronic or mechanical, including photocopying, or posting on the internet or an intranet, without prior written permission. Permission can be requested from either ISO at the address below or ISO's member body in the country of the requester.

ISO copyright office
CP 401 • Ch. de Blandonnet 8
CH-1214 Vernier, Geneva
Phone: +41 22 749 01 11
Email: copyright@iso.org
Website: www.iso.org

Published in Switzerland